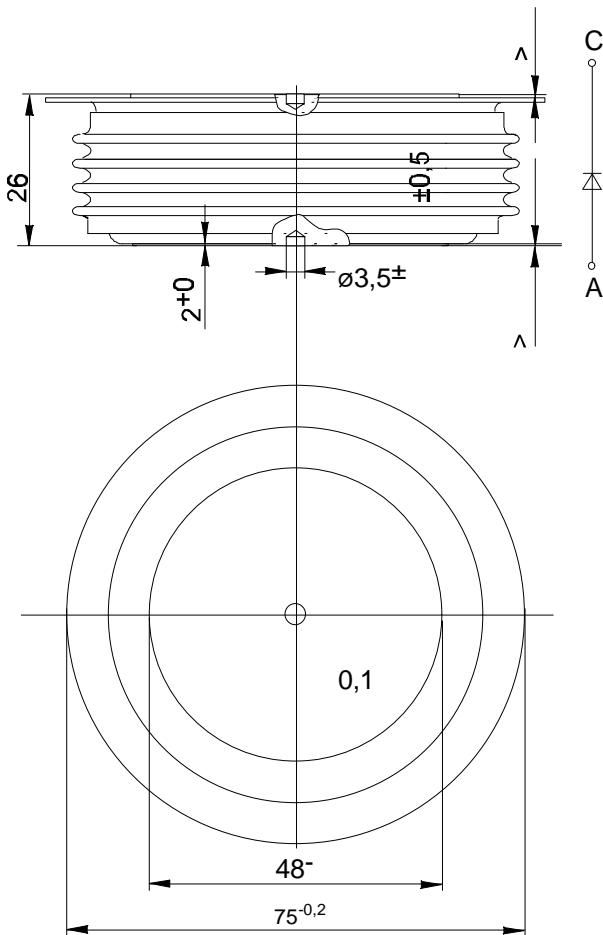


SSI R62F 250

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Maximum rated values

repetitive peak reverse voltage	$t_{vj} = -40^\circ\text{C} \dots 125^\circ\text{C}$	V_{RRM}	3500 V, 4000 V 4500 V
non-repetitive peak reverse voltage	$t_{vj} = +25^\circ\text{C} \dots 125^\circ\text{C}$	V_{RSM}	3600 V, 4100 V 4600
RMS forward current	$t_c = 85^\circ\text{C}$	I_{FRMSM}	1700 A
mean forward current	$t_c = 52^\circ\text{C}$	I_{FAVM}	720 A 1080 A
surge forward current, ¹⁾	$t_{vj} = 25^\circ\text{C}$ $t_{vj} = 125^\circ\text{C}$	I_{FSM}	16000 A 15000 A
integral I^2t -value	$t_{vj} = 25^\circ\text{C}$ $t_{vj} = 125^\circ\text{C}$	I^2t	$1,3 \times 10^6 \text{ A}^2\text{s}$ $1,13 \times 10^6 \text{ A}^2\text{s}$
critical repetitive rate of fall of on - state	$t_{vj} = 125^\circ\text{C}$, $I_M = 2000 \text{ A}$, $V_R = 3000 \text{ V}$ $C = 0,25 \mu\text{F}$, $R = 6$	$(-di/dt)_{com}$	500 A/ μ s

Characteristic values

cont. direct reverse voltage	$t_c = -40^\circ\text{C} \dots +85^\circ\text{C}$	$V_{R(D)}$	typ. 2000 V
forward voltage	$t_{vj} = 125^\circ\text{C}$, $I_M = 2500 \text{ A}$	V_F	3,5 V
threshold voltage	$t_{vj} = 125^\circ\text{C}$	$V_{(TO)}$	1,7 V
forward slope resistance	$t_{vj} = 125^\circ\text{C}$	r_T	0,69 m Ω
reverse current	$t_{vj} = 125^\circ\text{C}$, $V_R = 0,67 V_{RRM}$ $t_{vj} = 125^\circ\text{C}$, $V_R = V_{RRM}$	i_R	ca. 75 mA 140 mA ¹⁾
peak reverse recovery current	$i_{FM} = 1000 \text{ A}$, $-di/dt = 250 \text{ A}/\mu\text{s}$ $t_{vj} = 125^\circ\text{C}$; $V_R = 1000 \text{ V}$ $C = 0,25 \mu\text{F}$; $R = 6\Omega$	I_{RM}	600 A
recovered charge	$i_{FM} = 1000 \text{ A}$, $-di/dt = 250 \text{ A}/\mu\text{s}$ $t_{vj} = 125^\circ\text{C}$; $V_R = 1000 \text{ V}$ $C = 0,25 \mu\text{F}$; $R = 6\Omega$	Q_{rr}	1700 μ As

Thermal properties

thermal resistance, junction to case	Kühlfläche / cooling surface beidseitig / two-sided Anoden / anode Kathode / cathode	R_{thJC}	
			0,018 K/W
			0,033 K/W
			0,04 K/W
thermal resistance, case to heatsink	Kühlfläche / cooling surface beidseitig / two-sided einseitig / single-sided	R_{thCK}	
			0,005 K/W
			0,01 K/W
max. junction temperat.	t_{vjmax}		125 °C
operating temperature	$t_c op$		-40...+125 °C
storage temperature	t_{stg}		-40...+150 °C

Mechanical properties

case, see appendix	Seite / page 1
clamping force	F
Gewicht / weight	G
air distance	ca. 20 mm
creepage distance	30 mm
humidity classification	DIN 40040
vibration resistance	f = 50 Hz
	50 m/s ²

This technical information specifies semiconductor devices but promises no characteristics. It is valid in combination with the belonging technical notes.

Analytical elements of transient thermal impedance Z_{thJC} for DC

	1. Z_{thJC}		2. Z_{thJC}		3. Z_{thJC}	
	r [K/W]	τ [s]	r [K/W]	τ [s]	r [K/W]	τ [s]
1	0,00637	1,80000	0,02137	8,00000	0,02837	6,80000
2	0,00904	0,14000	0,00904	0,14000	0,00904	0,14000
3	0,00267	0,01410	0,00167	0,01410	0,00167	0,01410
4	0,00080	0,00265	0,00080	0,00265	0,00080	0,00265
5	0,00012	0,00067	0,00012	0,00067	0,00012	0,00067
Σ	0,00180	-	0,03300	-	0,04000	-

Analytical function:

$$Z_{thJC} = \sum_{n=1}^{n_{\max}} R_{thn} (1 - \text{EXP}(-t/\tau_n))$$